Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/607,062	YAMAMOTO ET AL.	
Examiner	Art Unit	
Nhon T. Diep	2621	

SEARCHED						
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)						
	DATE	EXMR				
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VO, TUNG	6/10/07	N.D.				
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